

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/604,818	CHANG, YI-CHEN	
Examiner		Michael Pervan	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,924,602	08-2005	Komiya, Naoaki	315/169.3
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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